

<b>Notice of References Cited</b>	Application/Control No. 10/573,770	Applicant(s)/Patent Under Reexamination LAIHO ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,083,221 A	04-1978	Whitted, Robert Lee	72/405.06
*	B	US-5,574,964 A	11-1996	Hamlin, Christopher L.	725/78 -
*	C	US-5,644,622 A	07-1997	Russell et al.	455/422.1
*	D	US-6,031,492 A	02-2000	Griffin et al.	343/702
*	E	US-6,091,931 A	07-2000	Ben-Efraim et al.	455/3.02
*	F	US-6,118,499 A	09-2000	Fang, George	348/726
*	G	US-6,239,769 B1	05-2001	Ericsson et al.	343/906
*	H	US-6,295,033 B1	09-2001	Chatzipetros et al.	343/713
*	I	US-6,317,089 B1	11-2001	Wilson et al.	343/713
*	J	US-2002/0003495 A1	01-2002	JOHNSTONE et al.	342/357.13
*	K	US-2002/0021371 A1	02-2002	Konishi et al.	348/678
*	L	US-6,434,187 B1	08-2002	Beard et al.	375/219
*	M	US-6,459,915 B2	10-2002	Nakamura et al.	455/571

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0014766 A1	01-2003	Dinwiddie et al.	725/126
*	B	US-2003/0192061 A1	10-2003	Hwangbo et al.	725/138
*	C	US-6,650,649 B1	11-2003	Muhammad et al.	370/402
*	D	US-2003/0231864 A1	12-2003	Wakahara, Tatsuya	386/68
*	E	US-2004/0090352 A1	05-2004	Jaffe et al.	341/050
*	F	US-2004/0137929 A1	07-2004	Jones et al.	455/517
*	G	US-2004/0171377 A1	09-2004	Engstrom, G Eric	455/419
*	H	US-2004/0248543 A1	12-2004	Itsukaichi, Atsushi	455/345
*	I	US-2005/0047426 A1	03-2005	Aaltonen et al.	370/432
*	J	US-2005/0071878 A1	03-2005	Asano et al.	725/078
*	K	US-6,892,080 B2	05-2005	Friesen et al.	455/571
*	L	US-2005/0186931 A1	08-2005	Laiho et al.	455/280
*	M	US-6,952,576 B2	10-2005	Fish et al.	455/414.1

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

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	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0253973 A1	11-2005	Adachi et al.	348/838
*	B	US-2005/0288059 A1	12-2005	Maejima et al.	455/557
*	C	US-2006/0212910 A1	09-2006	Endres et al.	725/073
*	D	US-7,107,063 B1	09-2006	Bates et al.	455/456.1
*	E	US-7,133,082 B2	11-2006	Limberg, Allen Le Roy	348/725
*	F	US-7,184,722 B1	02-2007	Johnson et al.	455/127.1
*	G	US-2007/0197264 A1	08-2007	Itsukaichi, Atsushi	455/569.2
*	H	US-5,822,705	10-1998	Lehtola, Antero	455/575.7
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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